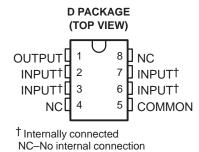
- 3-Terminal Regulators
- Output Current Up to 100 mA
- No External Components Required
- Internal Thermal-Overload Protection
- Internal Short-Circuit Current Limiting
- Direct Replacement for Motorola MC79L00 Series
- Available in 5% or 10% Selections

description

This series of fixed negative-voltage integrated-circuit voltage regulators is designed for a wide range of applications. These include on-card regulation for elimination of noise and distribution problems associated with single-point regulation. In addition,



LP PACKAGE (TOP VIEW)



they can be used to control series pass elements to make high-current voltage-regulator circuits. One of these regulators can deliver up to 100 mA of output current. The internal current-limiting and thermal-shutdown features make them essentially immune to overload. When used as a replacement for a zener-diode and resistor combination, these devices can provide an effective improvement in output impedance of two orders of magnitude, with lower bias current.

The MC79L00C series is characterized for operation over the virtual junction temperature range of 0°C to 125°C.

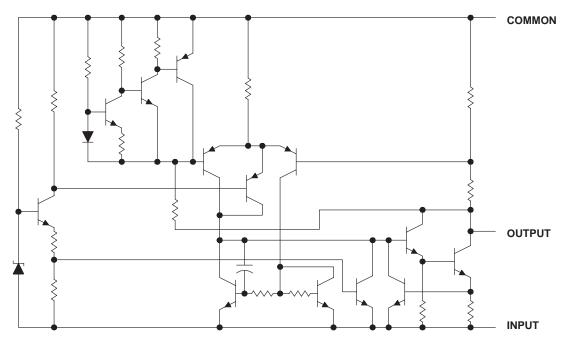
AVAILABLE OPTIONS

			PACKAGE	D DEVICES				
	NOMINAL OUTPUT	OUTPUT VOLTAGE TOLERANCE						
TJ	VOLTAGE (V)	SMALL (_	PLASTIC CYLINDRICAL (LP)				
	. ,	5% 10%		5%	10%			
0°C to 125°C	−5 −12 −15	MC79L05ACD [‡] MC79L12ACD [‡] MC79L15ACD	– MC79L12CD MC79L15CD	MC79L05ACLP‡ MC79L12ACLP‡ MC79L15ACLP§	– MC79L12CLP –			

[‡]This device is available taped and reeled. Add the suffix R to the device type (e.g., MC79L05ACDR).

[§] This device is available taped and reeled or in ammo pack. Add the suffix M to the device type for ammo pack (e.g., MC79L15ACLPM).

equivalent schematic



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Input voltage: MC79L05	
MC79L12, MC79L15	
Operating free-air, case, or virtual junction temperature	150°C
Package thermal impedance, θ_{JA} (see Notes 1 and 2): D package	je 97°C/W
LP packa	ge196°C/W
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C
Storage temperature range, T _{sto}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		MIN	MAX	UNIT
	MC79L05	-7	-20	
Input voltage, V _I	MC79L12	-14.5	-27	V
	MC79L15	-17.5	-30	
Output current, IO			100	mA
Operating virtual junction temperature, T _J				°C



NOTES: 1. Maximum power dissipation is a function of $T_J(max)$, θ_{JA} , and T_A . The maximum allowable power dissipation at any allowable ambient temperature is $P_D = (T_J(max) - T_A)/\theta_{JA}$. Operating at the absolute maximum T_J of 150°C can impact reliability.

^{2.} The package thermal impedance is calculated in accordance with JESD 51.

electrical characteristics at specified virtual junction temperature, $V_I = -10 \text{ V}$, $I_O = 40 \text{ mA}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	TJ	М	C79L050	3	MC79L05AC			UNIT
PARAMETER			MIN	TYP	MAX	MIN	TYP	MAX	UNIT
Output voltage‡		25°C	-4.6	-5	-5.4	-4.8	-5	-5.2	
	$V_I = -7 \text{ V to } -20 \text{ V},$ $I_O = 1 \text{ mA to } 40 \text{ mA}$	0°C to 125°C	-4.5		-5.5	-4.75		-5.25	V
	$V_I = -10 \text{ V},$ $I_O = 1 \text{ mA to 70 mA}$	0°C to 125°C	-4.5		-5.5	-4.75		-5.25	
Input regulation	$V_{I} = -7 \text{ V to } -20 \text{ V}$	- 25°C			200			150	mV
Input regulation	$V_{ } = -8 \text{ V to } -20 \text{ V}$				150			100	IIIV
Ripple rejection	$V_I = -8 \text{ V to } -18 \text{ V},$ f = 120 Hz	25°C	40	49		41	49		dB
Outrout no mulation	I _O = 1 mA to 100 mA	25°C			60			60	\/
Output regulation	I _O = 1 mA to 40 mA				30			30	mV
Output noise voltage	f = 10 Hz to 100 kHz	25°C		40			40		μV
Dropout voltage	I _O = 40 mA	25°C		1.7			1.7		V
Bias current		25°C 125°C			6			6	\/
					5.5			5.5	mV
Dies surrent change	$V_{ } = -8 \text{ V to } -20 \text{ V}$	0°C to 105°C			1.5			1.5	\/
Bias current change	I _O = 1 mA to 40 mA	0°C to 125°C			0.2			0.1	mV

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. ‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_I = -19$ V, $I_O = 40$ mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	ТЈ	MC	C79L12C	МС	MC79L12AC		
			MIN	TYP MAX	MIN	TYP	MAX	UNIT
Output voltage‡		25°C	-11.1	-12 -12.9	-11.5	-12	-12.5	V
	$V_I = -14.5 \text{ V to } -27 \text{ V},$ $I_O = 1 \text{ mA to } 40 \text{ mA}$	0°C to 125°C	-10.8	-13.2	-11.4		-12.6	
	$V_I = -19 \text{ V},$ $I_O = 1 \text{ mA to 70 mA}$	0°C to 125°C	-10.8	-13.2	-11.4		-12.6	
Input regulation	$V_{ } = -14.5 \text{ V to } -27 \text{ V}$	25°C		250			250	mV
Input regulation	$V_{I} = -16 \text{ V to } -27 \text{ V}$			200			200	IIIV
Ripple rejection	$V_I = -15 \text{ V to } -25 \text{ V},$ f = 120 Hz	25°C	36	42	37	42		dB
Output regulation	I _O = 1 mA to 100 mA	25°C		100			100	mV
Output regulation	I _O = 1 mA to 40 mA			50			50	IIIV
Output noise voltage	f = 10 Hz to 100 kHz	25°C		80		80		μV
Dropout voltage	I _O = 40 mA	25°C		1.7		1.7		V
Pigg gurrant		25°C		6.5			6.5	mV
Bias current		125°C		6			6	IIIV
Pigg gurrent change	$V_{I} = -16 \text{ V to } -27 \text{ V}$	0°C to 125°C		1.5			1.5	mV
Bias current change	$I_O = 1 \text{ mA to } 40 \text{ mA}$	0 0 10 125 0		0.2			0.1	IIIV

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. ‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.



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electrical characteristics at specified virtual junction temperature, $V_I = -23$ V, $I_O = 40$ mA (unless otherwise noted)

DADAMETED	TEST CONDITIONS†	TJ	M	C79L15	С	MC	UNIT		
PARAMETER			MIN	TYP	MAX	MIN	TYP	MAX	UNII
Output voltage‡		25°C	-13.8	-15	-16.2	-14.4	-15	-15.6	V
	$V_I = -17.5 \text{ V to } -30 \text{ V},$ $I_O = 1 \text{ mA to } 40 \text{ mA}$	0°C to 125°C	-13.5		-16.5	-14.25		-15.75	
	$V_{I} = -23 \text{ V},$ $I_{O} = 1 \text{ mA to } 70 \text{ mA}$	0°C to 125°C	-13.5		-16.5	-14.25		-15.75	
lancet an avelation	$V_I = -17.5 \text{ V to } -30 \text{ V}$	25°C			300			300	\/
Input regulation	$V_I = -17.5 \text{ V to } -30 \text{ V}$				250			250	mV
Ripple rejection	$V_I = -18.5 \text{ V to } -28.5 \text{ V},$ f = 120 Hz	25°C	33	39		34	39		dB
Outrout as mulation	I _O = 1 mA to 100 mA	25°C			150			150	\/
Output regulation	I _O = 1 mA to 40 mA				75			75	mV
Output noise voltage	f = 10 Hz to 100 kHz	25°C		90			90		μV
Dropout voltage	I _O = 40 mA	25°C		1.7			1.7		V
Diag sumant		25°C			6.5			6.5	
Bias current		125°C			6			6	mV
Pigg gurrent change	$V_{I} = -20 \text{ V to } -30 \text{ V}$	0°C to 125°C			1.5			1.5	mV
Bias current change	$I_O = 1 \text{ mA to } 40 \text{ mA}$	0°C to 125°C			0.2			0.1	IIIV

 $^{^{\}dagger}$ All characteristics are measured with a 0.33- μ F capacitor across the input and a 0.1- μ F capacitor across the output. Pulse-testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.





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